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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant(s): Dvir, Eran; Haimovich, Eli; Shulman, Benjamin  
Assignee: Nova Measuring Instruments Ltd  
Title: APPARATUS FOR OPTICAL INSPECTION OF WAFERS DURING POLISHING  
Serial No.: 08/497,382 Filed: 06/29/95  
Batch No.: U26 Date Allowed: November 17, 1997  
Examiner: E. Morgan Group Art Unit: 3203  
Docket No.: M-3417 US

San Jose, California

OFFICE OF PATENT PUBLICATIONS  
Attn: Toni Hood  
ASSISTANT COMMISSIONER FOR PATENTS  
Washington, D. C. 20231

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Publishing Division

**MAR 10 2000**

**RE-SUBMISSION OF FORMAL DRAWINGS**

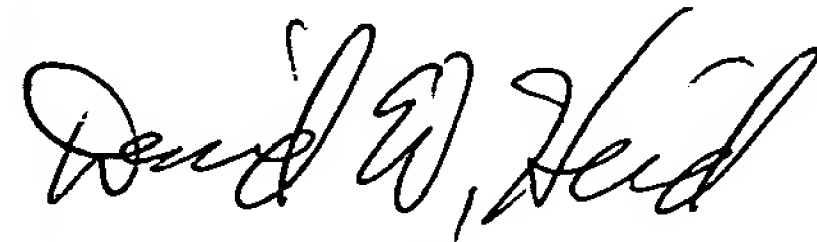
Dear Sir:

Applicants understand from a telephone conversation between the undersigned and Toni Hood of the Office of Patent Publications that the formal drawings for this case apparently have become lost in the Patent Office. Accordingly, Applicants resubmit new formal drawings for entry in the case to place the case in condition for issuance. The original formal drawings were submitted at the time of payment of the issue fee. Applicants enclose a copy of the Submission of Formal Drawings document dated February 17, 1998, signed and dated by the undersigned and including a First Class Mailing Certificate along with a copy of the postcard which was included with the formal drawings and other matters entered at that time as well as a copy of the postcard showing a date stamped receipt by the Publishing Division.

Applicant(s) submit(s) seven (7) sheets of formal drawings, consisting of Figures 1, 2, 3, 4, 5, 6, 7, 8, 9, 10, 11, 12 and 13, in the above-named application. If there are any questions regarding these drawings, please call the undersigned at (408) 453-9200.

**HAND DELIVERED**

Respectfully submitted,



David W. Heid  
Attorney for Applicant(s)  
Reg. No. 25,875